

<b>Notice of References Cited</b>	Application/Control No. 10/531,686		Applicant(s)/Patent Under Reexamination HIRAMATSU ET AL.	
	Examiner ISAAC T. TECKLU		Art Unit 2192	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0188934	12-2002	Griffioen et al.	717/170
*	B	US-2004/0015952	01-2004	Lajoie et al.	717/171
*	C	US-2003/0088868	05-2003	Chang et al.	717/173
*	D	US-2004/0034861 A1	02-2004	Ballai, Philip N.	719/321
*	E	US-2003/0110346 A1	06-2003	Katahira, Shunsuke	711/103
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.